

# Lecture Note #13

## Photoelectrochemistry (ch. 18)

1. Electrogenenerated Chemiluminescence
2. Photoelectrochemistry at Semiconductors

# Photoelectrochemistry

**Radiation energy  $\Leftarrow$  electrical or chemical energy**

**e.g., ECL, electrochromic device, EL, sensors**

## **General Concepts of luminescence**

- **the type of excitation**

- Photoluminescence: light emission by UV or visible light
- Radioluminescence (scintillation): excited by radioactive substances
- Cathodoluminescence: excited by high velocity electron bombardment
- X-ray luminescence: by X-rays
- Chemiluminescence: by chemical reactions

**-Electrochemiluminescence or electrogenerated chemiluminescence: by electrochemical reactions**

- Electroluminescence: by electric voltage

- **Luminescent materials** (or luminophors): substances which exhibit luminescence

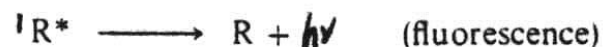
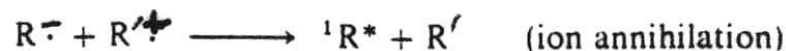
- organic (organoluminophors)
- inorganic (phosphors)

## Electrochemiluminescence (or electrogenerated chemiluminescence, ECL)

- solution phase chemiluminescence resulting from electron transfer reactions, often involving aromatic radical ions

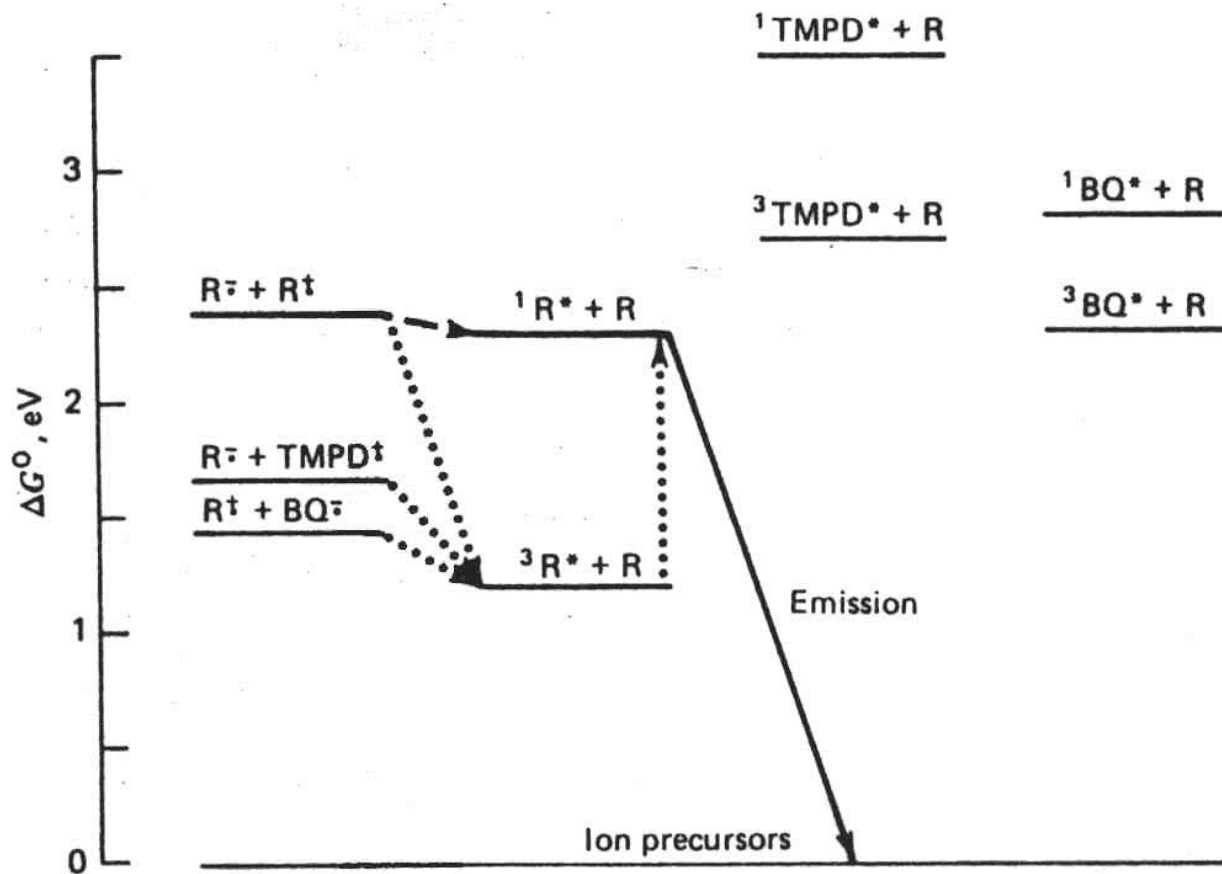
- general reaction mechanisms

- S route: “energy sufficient” (energy released by the electron transfer process is sufficient to raise a product to the emitting state)



where  $R^{\cdot-}$  and  $R'^{\cdot+}$  may be derived from the same or different *precursors*, R and R'. For example, R and R' might both be rubrene, or R could be 9,10-diphenylanthracene and R' could be thianthrene (Fig. 1). We show

- T route: “energy deficient” (the energy available in electron transfer is substantially less than that required to reach the emitting state), triplet intermediates



**Figure 14.4.1**

Energetics for chemiluminescent reactions of rubrene radical ions. All energies measured with respect to ground-state neutral species. Dashed arrow shows *S* route. Dotted arrows show *T* route. Promotion from  $^3R^* + R$  to  $^1R^* + R$  requires another rubrene triplet.

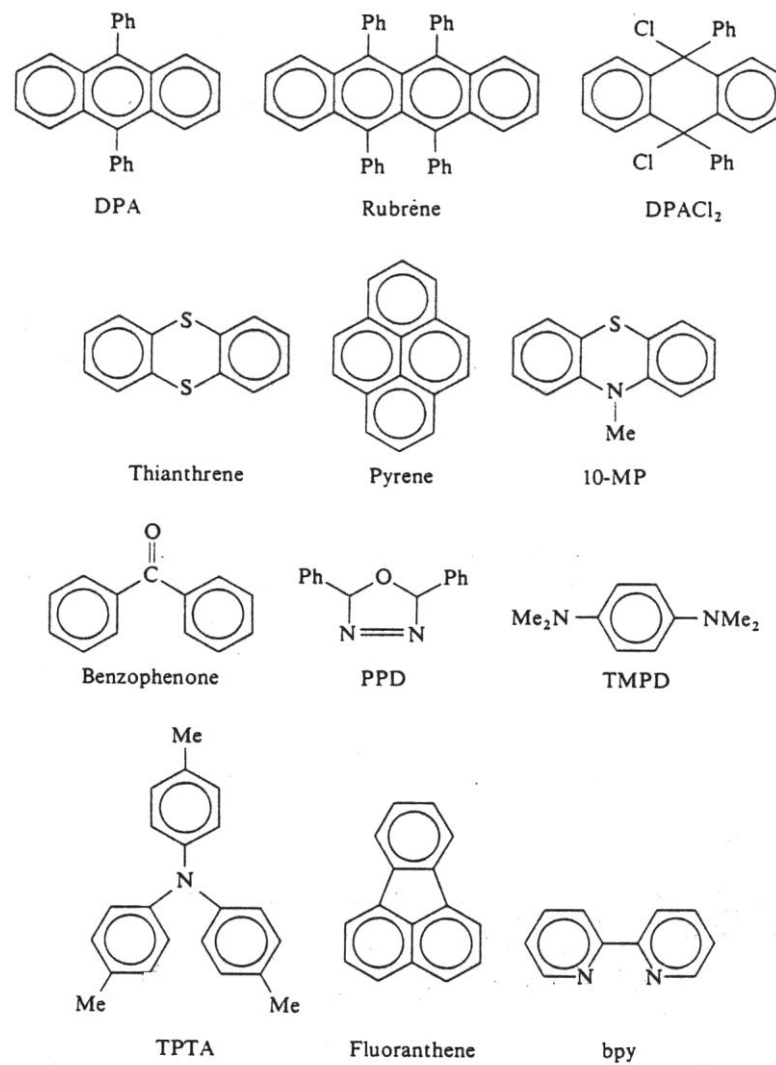
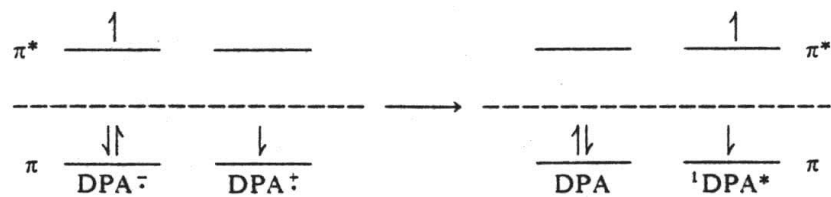


Fig. 1. Structures of compounds.

- experimental techniques

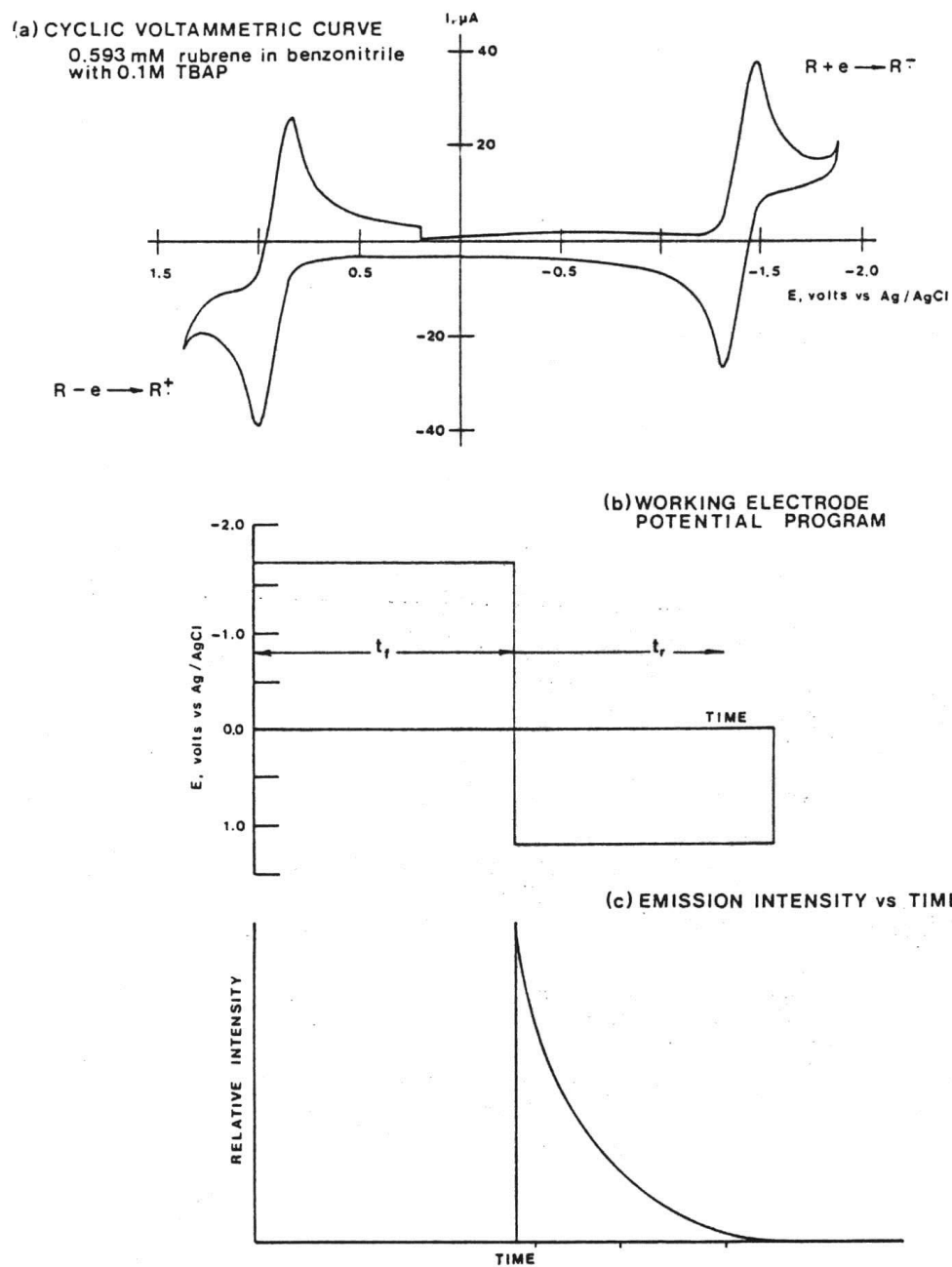
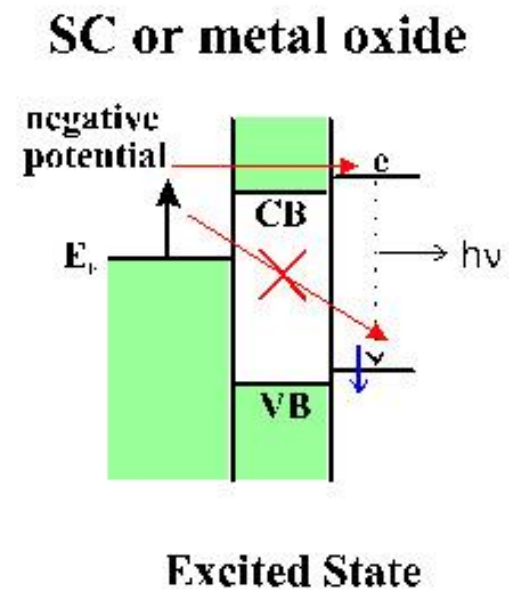
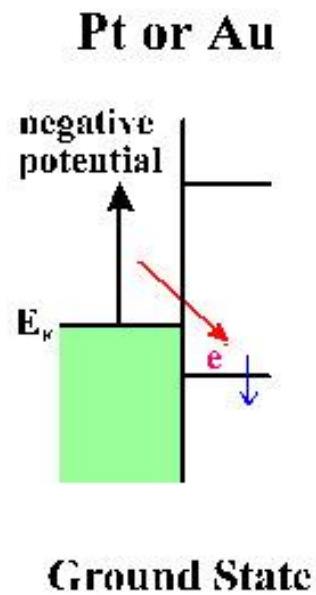
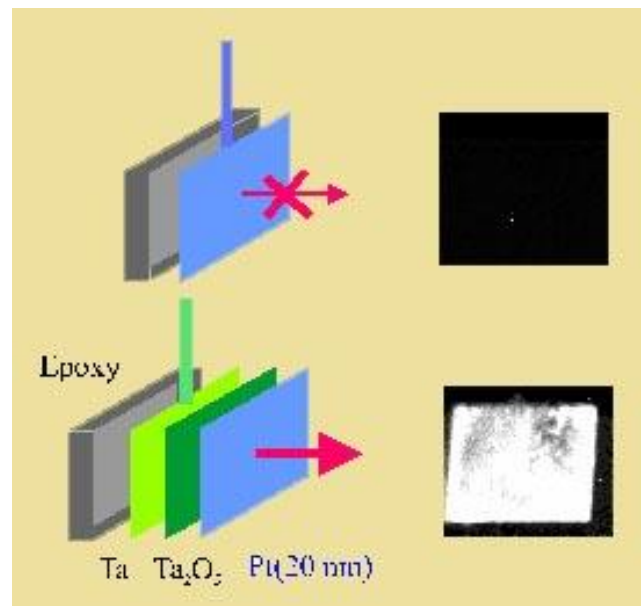
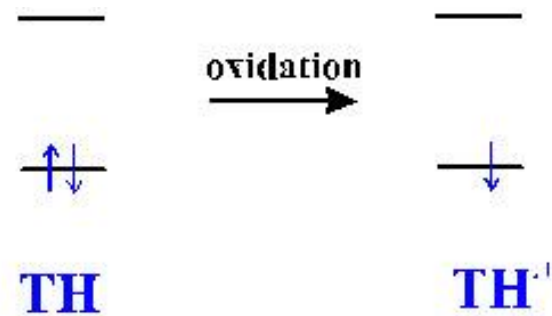
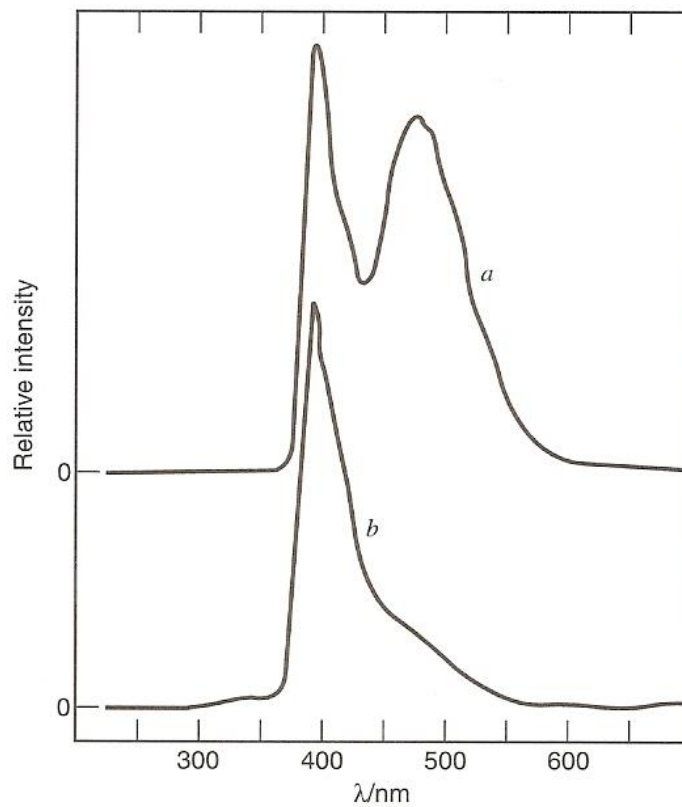


Fig. 3. The generation of ECL in a sequential step experiment. From Faulkner and Bard (1977), with permission from Marcel Dekker, Inc.

- ECL at semiconductors



## ECL in Pyrene (Py) and TMPD solution: 400 nm & 450 nm



**(a) ECL (b) Fluorescence (excitation at 350 nm)**



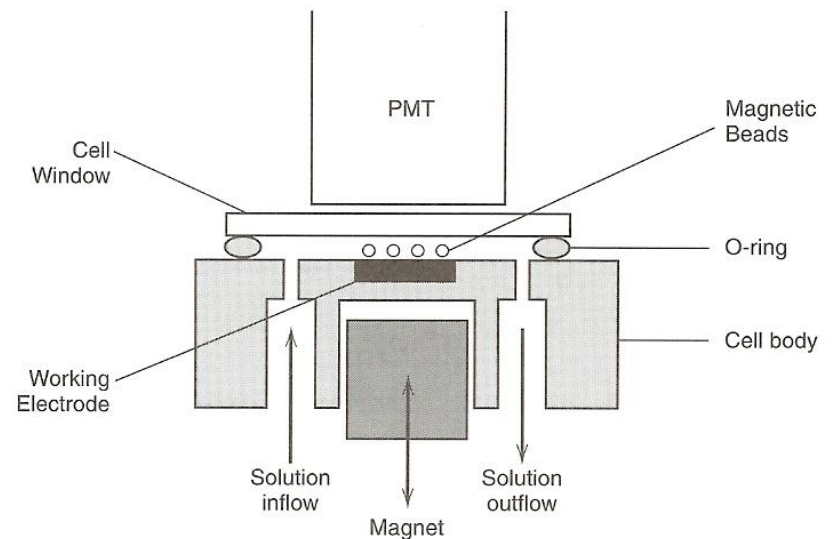
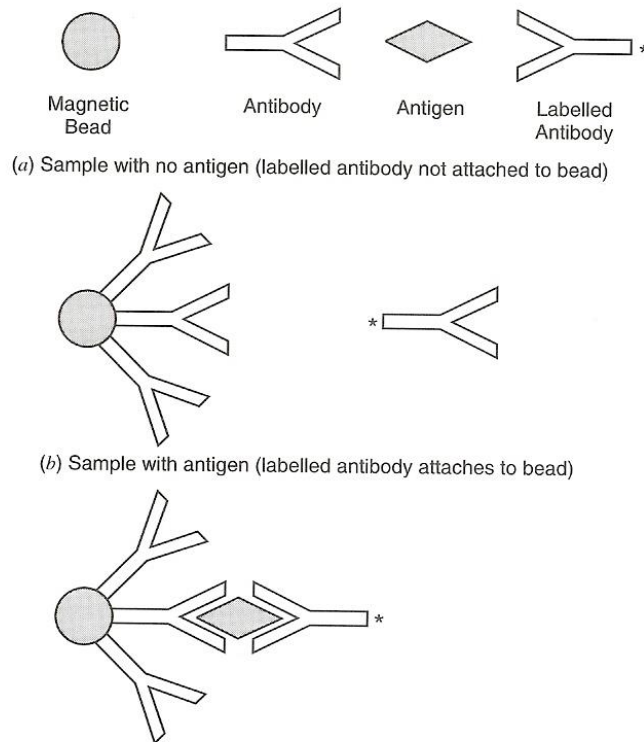
# Analytical applications of ECL

Light intensity is proportional to concentration → analysis using ECL

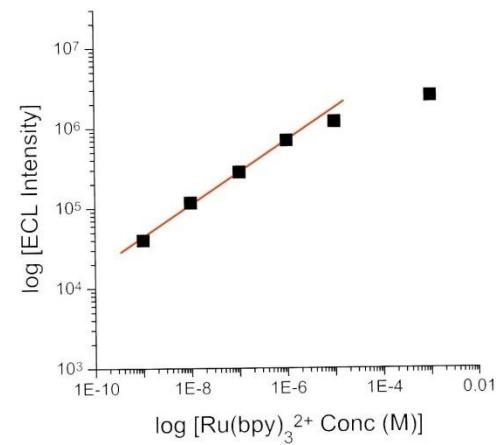
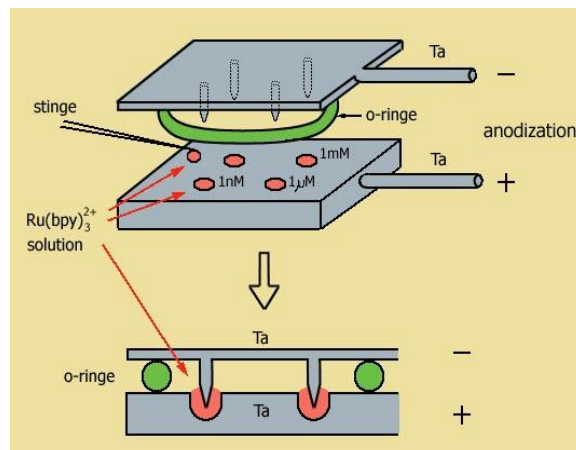
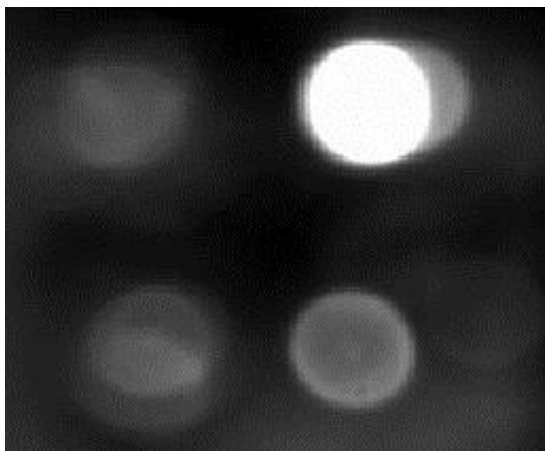
-Very sensitive: very low light level

-No light source is needed: electrochemical excitation

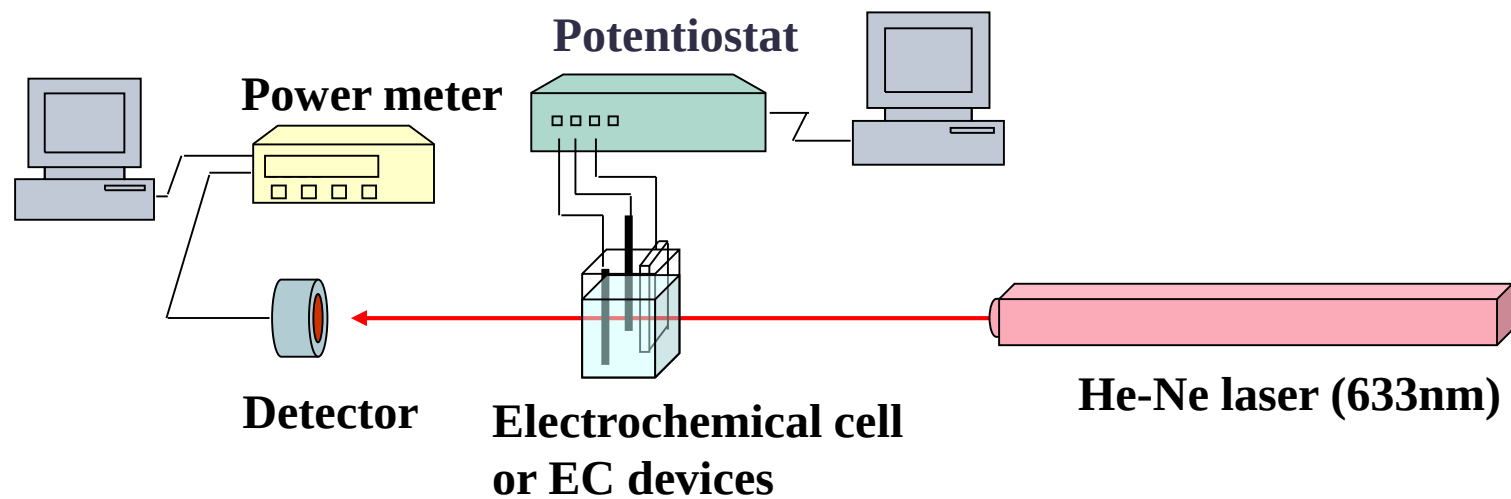
Most frequently used ECL-active label:  $\text{Ru}(\text{bpy})_3^{2+}$



# Electro(chemi)luminescent Devices



## In-situ transmittance test

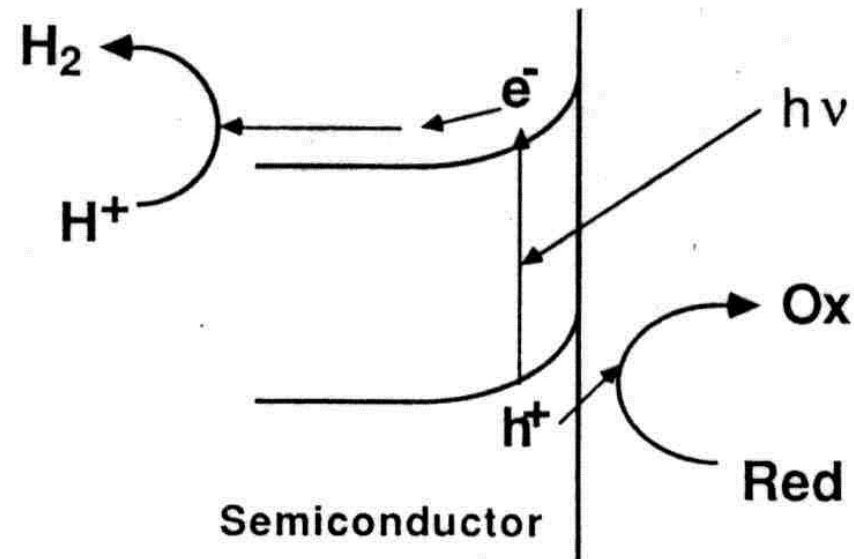


## Photoelectrochemistry at semiconductors

Radiation energy  $\Leftrightarrow$  electrical or chemical energy

- **photoelectrochemical system:** absorption of light by the system (e.g., sun light)  
→ chemical reactions & flow of current

- semiconductor:  
absorb photons  $\rightarrow$  electron-hole pairs  $\Rightarrow$  oxidation/reduction reactions  $\rightarrow$  products  
(photocurrent)



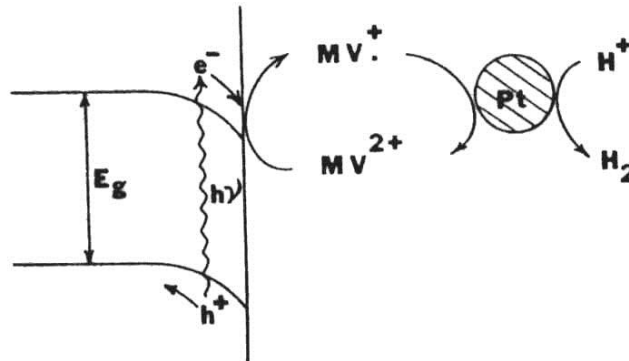
- Hydrogen fuel production ( $\text{H}^+$  or  $\text{H}_2\text{O}$  reduction): i) kinetically difficult  $\rightarrow$  catalyst, ii) recombining electrons and holes and lowering the efficiency of the photoreaction unless rapid chemical reaction



Red: sacrificial (electron) donor

e.g., Photoproduction of  $\text{H}_2$  on p-GaAs with methyl viologen & colloidal Pt  
(*J. Am. Chem. Soc.*, 102, 1488 (1980))

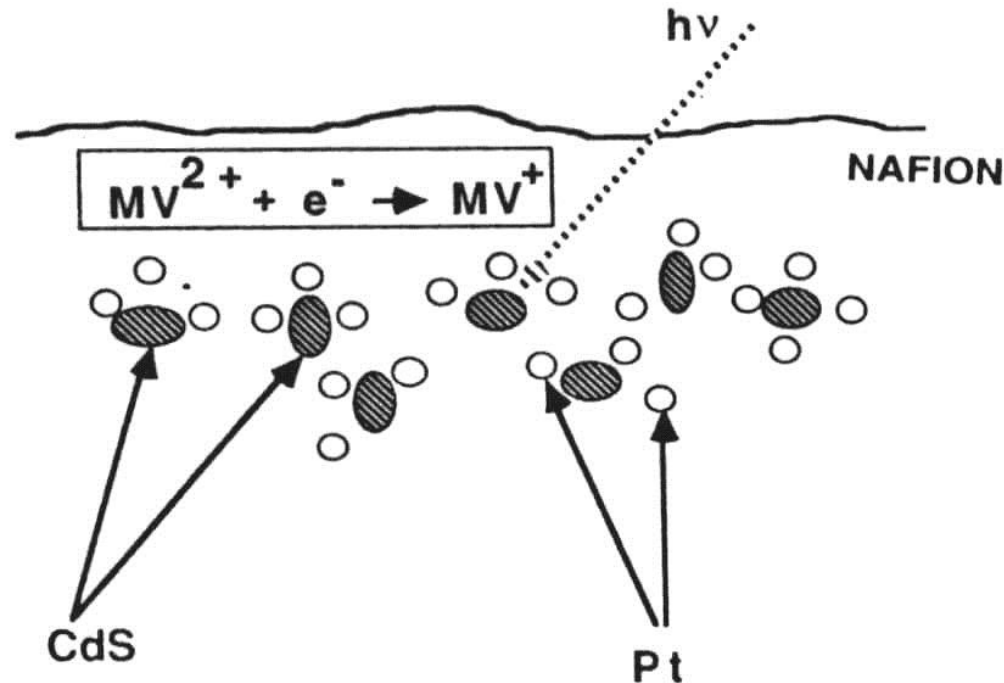
**p - GaAs / Electrolyte / Catalyst(suspended)**



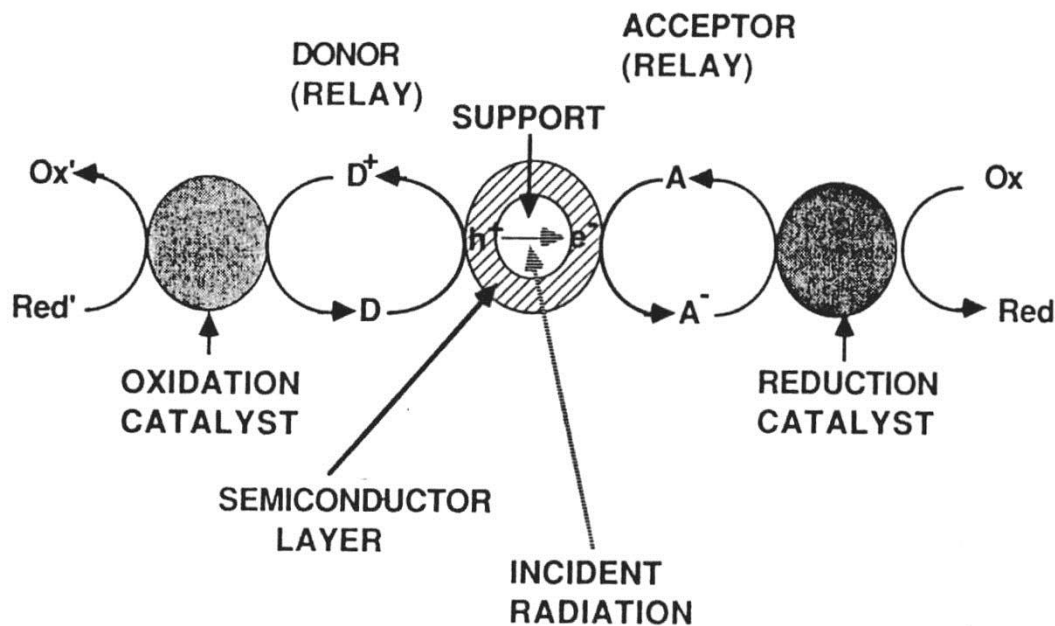
$$h\nu \geq E_g \text{ (band gap)}$$

Very slow  $\text{H}_2$  photoreaction on GaAs (high hydrogen overpotential)  $\rightarrow$  fast reaction of  $\text{MV}^{2+/1+} + \text{Pt}$  (fast hydrogen evolution)  $\rightarrow$  viologen + polymer/self assembly etc

**e.g., CdS particles in Nafion**



- General photoelectrochemical system for conversion of solar energy(sunlight) to useful chemical products



e.g.,  $H_2O \rightarrow 2H_2 + O_2$  or  $H_2, Cl_2, OH^-$  from NaCl solution

TABLE 6.1.1. Representative Half-Reactions of Interest in Photoelectrochemistry

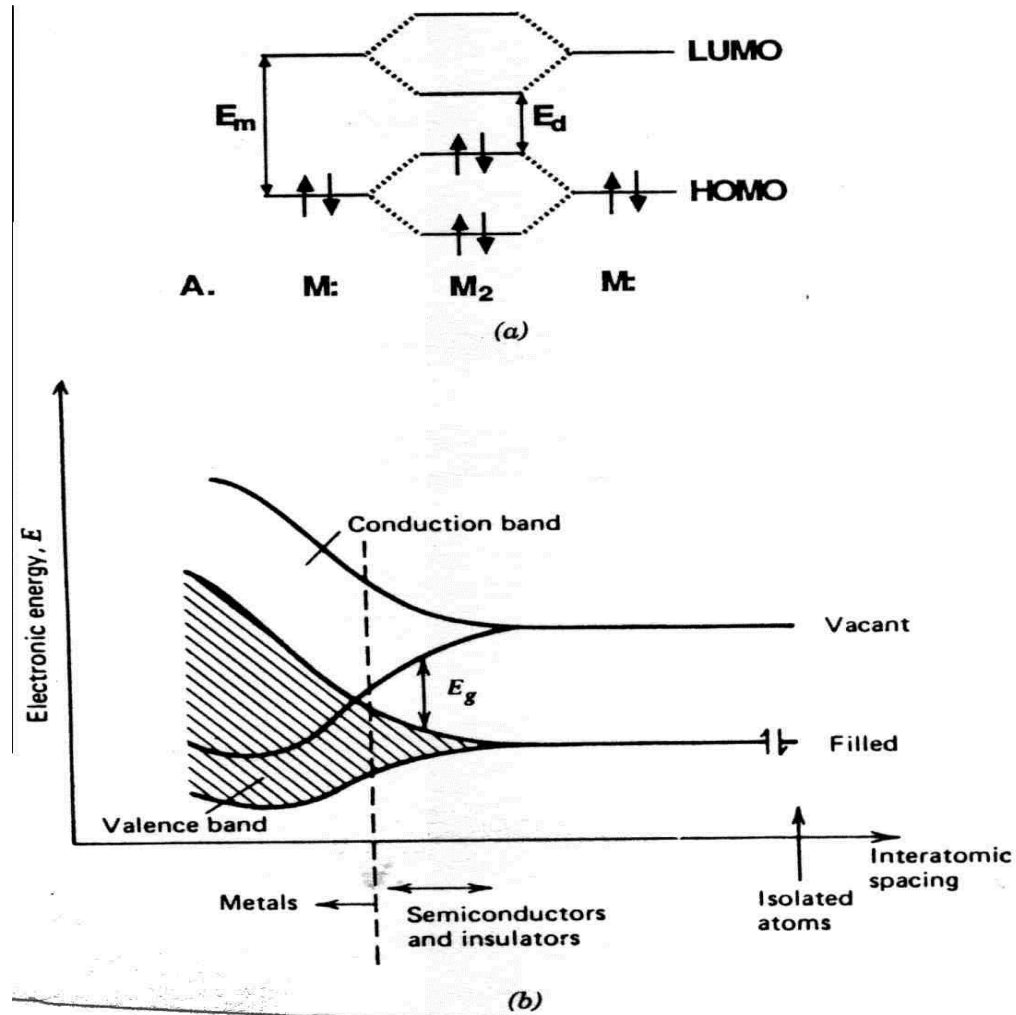
| Reductions |          |                      | Oxidations   |                   |                       |
|------------|----------|----------------------|--------------|-------------------|-----------------------|
| Ox         | Red      | Application          | Red'         | Ox'               | Application           |
| $H^+$      | $H_2$    | Fuel generation      | $Cl^-$       | $Cl_2$            | Disinfection          |
| $CO_2$     | $CH_4$   | Fuel generation      | $Br^-$       | $Br_2$            | Energy storage        |
| $Cu^{2+}$  | $Cu$     | Metal removal        | Organic      | $CO_2$            | Wastewater treatment  |
| $Ag^+$     | $Ag$     | Metal recovery       | $CN^-$       | $CNO^-$           | Wastewater treatment  |
| $Pt(IV)$   | $Pt$     | Catalyst preparation | $H_2O$       | $O_2$             | Inexpensive reductant |
| $O_2$      | $H_2O_2$ | Synthesis            | $CH_3CO_2^-$ | $CO_2, CH_3\cdot$ | Synthesis             |



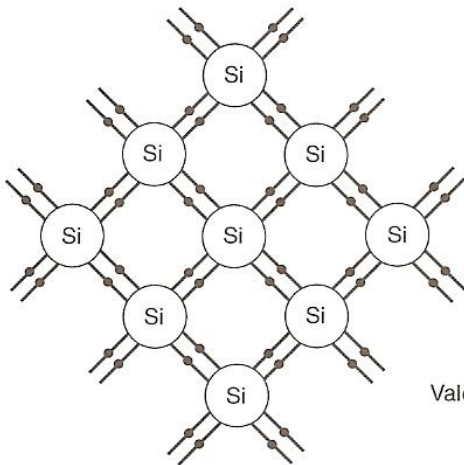
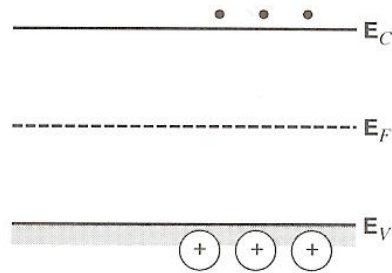
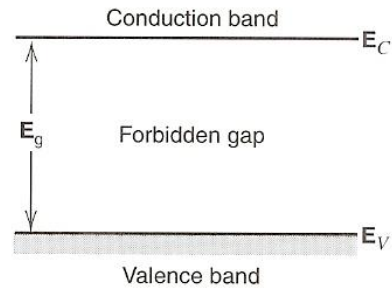
- Energy transduction step
  - 1) adsorption of a photon of incident light & conversion to an electron-hole pair ( $e^-h^+$ )
  - 2) electron & hole react with relays or mediators (serve the role of capturing  $e^-$  &  $h^+$ , thereby preventing the backreaction (recombination of  $e^-$  &  $h^+$  to produce heat))
  - 3) conducting these charges to catalyst centers where the final reactions occur

# Semiconductor electrodes

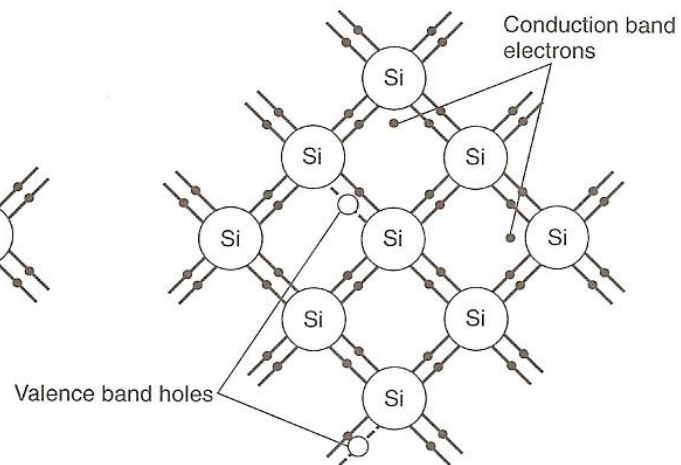
## Band model



# intrinsic semiconductor; undoped



(a)



(b)

- intrinsic semiconductor; # of  $e^-(n_i)$  &  $h^+(p_i)$  per  $\text{cm}^3$  at T

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$$n_i = p_i = (N_C N_V)^{1/2} \exp \left[ -\frac{E_g}{2kT} \right]$$
$$N_C = 2 \left( \frac{2\pi m_n kT}{h^2} \right)^{3/2} = (4.83 \times 10^{15}) (m_e^* T)^{3/2}$$
$$N_V = 2 \left( \frac{2\pi m_p kT}{h^2} \right)^{3/2} = (4.83 \times 10^{15}) (m_h^* T)^{3/2}$$

Where T(K),  $m_n$ ,  $m_p$ ; reduced masses of  $e^-$  &  $h^+$ ,  $m_e^*$ ,  $m_h^*$ ; relative effective masses where  $m_e^* = m_n/m_0$ ,  $m_h^* = m_p/m_0$  ( $m_0$ ; rest mass of an electron)

$$n_i = p_i \sim 2.5 \times 10^{19} \exp(-E_g/2kT) \text{ cm}^{-3} \text{ (near } 25^\circ\text{C)}$$

For Si,  $n_i = p_i \sim 1.4 \times 10^{10} \text{ cm}^{-3}$

$E_g > 1.5 \text{ eV} \rightarrow$  few carriers: electrical insulators

TABLE 6.2.1. Energy Gaps ( $E_g$ ) of Selected Materials

| Substance           | $E_g$ (eV) | Substance                      | $E_g$ (eV) |
|---------------------|------------|--------------------------------|------------|
| Ge                  | 0.67       | Fe <sub>2</sub> O <sub>3</sub> | ~ 2.3      |
| CuInSe <sub>2</sub> | 0.9        | CdS                            | 2.42       |
| Si                  | 1.12       | ZnSe                           | 2.58       |
| WSe <sub>2</sub>    | ~ 1.1      | WO <sub>3</sub>                | 2.8        |
| MoSe <sub>2</sub>   | ~ 1.1      | TiO <sub>2</sub> (rutile)      | 3.0        |
| InP                 | 1.3        | TiO <sub>2</sub> (anatase)     | 3.2        |
| GaAs                | 1.4        | ZnO (zincite)                  | 3.2        |
| CdTe                | 1.50       | SrTiO <sub>3</sub>             | 3.2        |
| CdSe                | 1.74       | SnO <sub>2</sub>               | 3.5        |
| GaP                 | 2.2        | ZnS (zinc blende)              | 3.54       |
|                     |            | C (diamond)                    | 5.4        |

TABLE 6.2.2. Properties of Si and GaAs

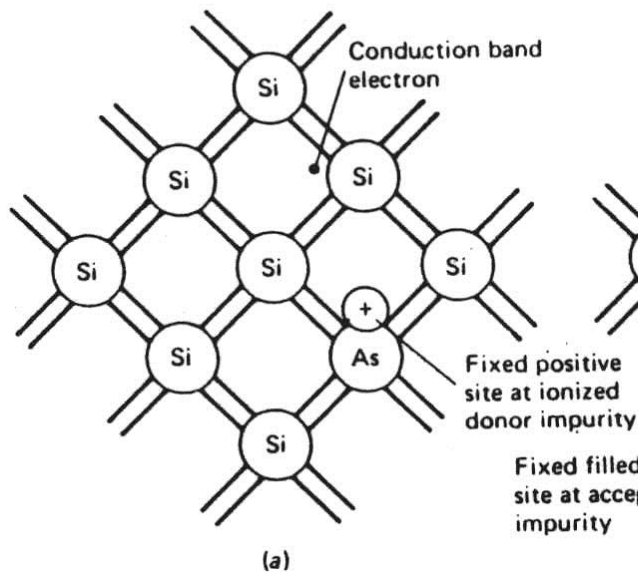
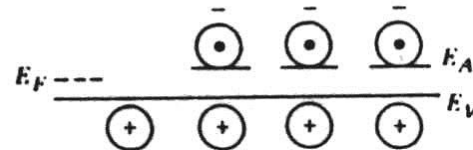
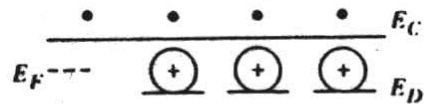
| Property                                                                     | Si                    | GaAs                  |
|------------------------------------------------------------------------------|-----------------------|-----------------------|
| Atoms/cm <sup>3</sup>                                                        | $5.0 \times 10^{22}$  | $2.21 \times 10^{22}$ |
| $E_g$ (eV) at 300 K                                                          | 1.12                  | 1.43                  |
| Crystal structure                                                            | Diamond               | Zinc blende           |
| Density (g/cm <sup>3</sup> )                                                 | 2.328                 | 5.32                  |
| Effective density of states<br>in conduction band, $N_C$ (cm <sup>-3</sup> ) | $2.8 \times 10^{19}$  | $4.7 \times 10^{17}$  |
| Effective density of states<br>in valence band, $N_V$ (cm <sup>-3</sup> )    | $1.02 \times 10^{19}$ | $7.0 \times 10^{18}$  |
| Effective mass ( $m^*/m_0$ )                                                 |                       |                       |
| Electrons                                                                    | 0.97, 0.19            | 0.068                 |
| Holes                                                                        | 0.16, 0.5             | 0.12, 0.5             |
| Dielectric constant                                                          | 11.8                  | 10.9                  |
| $n_i, p_i$ (cm <sup>-3</sup> ) at 300 K                                      | $6.8 \times 10^9$     | $1.8 \times 10^6$     |
| Mobility (cm <sup>2</sup> V <sup>-1</sup> s <sup>-1</sup> ) at 300 K         |                       |                       |
| Electrons                                                                    | 1900                  | 8800                  |
| Holes                                                                        | 500                   | 400                   |

- Mobilities ( $\mu$ , cm<sup>2</sup>V<sup>-1</sup>s<sup>-1</sup>) vs. diffusion coefficient (cm<sup>2</sup>s<sup>-1</sup>)

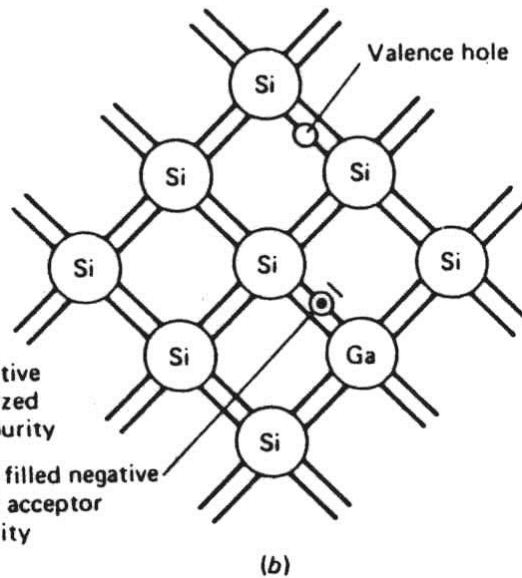
$$D_i = kT\mu_i = 0.0257\mu \text{ at } 25^\circ\text{C}, \quad i = n, p$$

## Extrinsic semiconductors; doped

- dopants or impurity; ~ppm, typical donor densities ( $N_D$ ) are  $10^{15}$ - $10^{17}$  cm<sup>-3</sup>

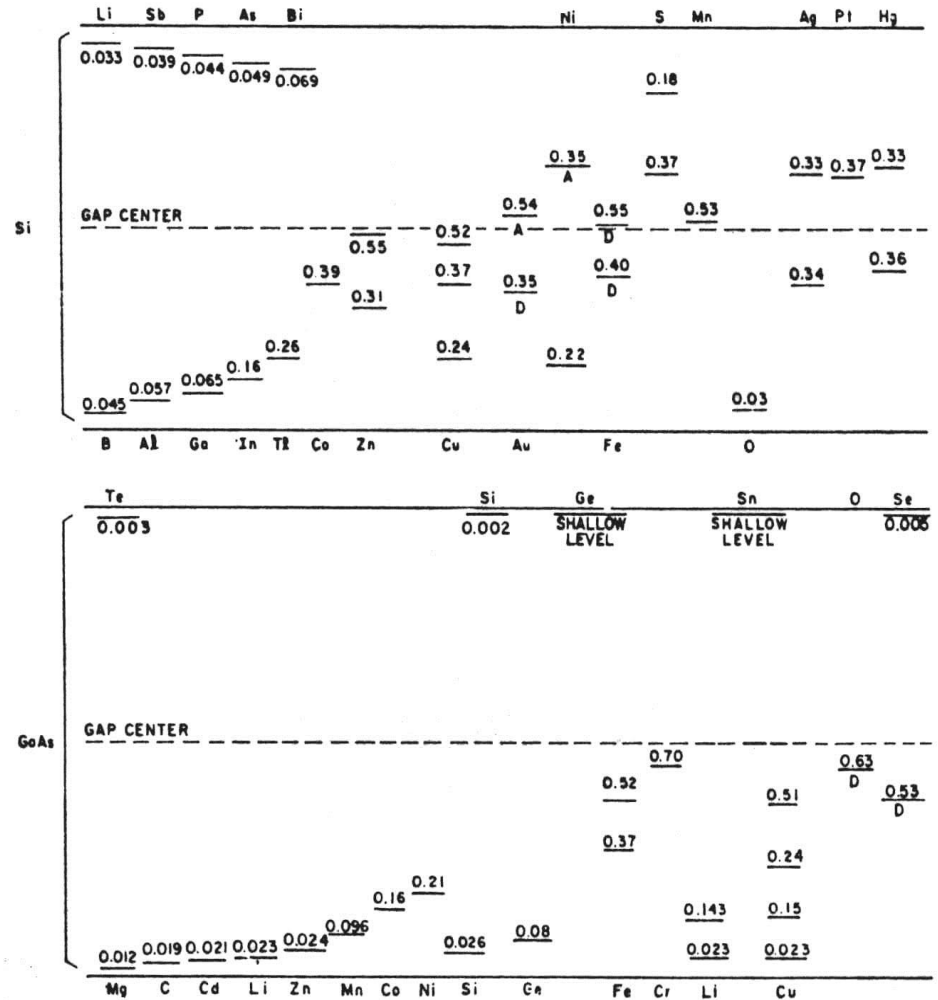
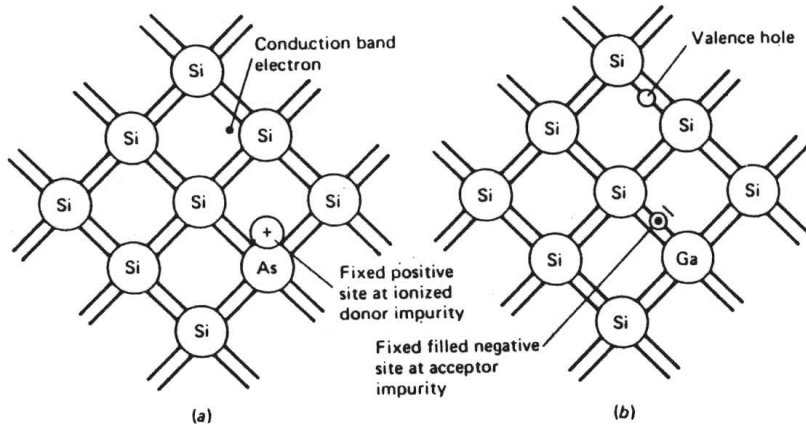
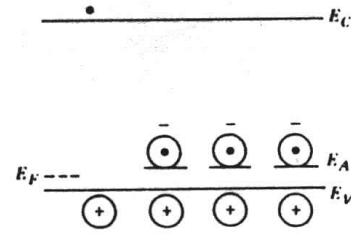
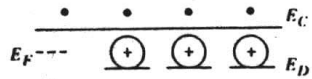


n-type



p-type

- Extrinsic semiconductors; doped
  - dopants or impurity; ~ppm, typical donor densities ( $N_D$ ) are  $10^{15}$ - $10^{17}$  cm<sup>-3</sup>





n-type: total density (n) of electrons in CB

$n = p + N_D$ , p; hole density (thermal activation of VB atoms)

most cases for moderate doping  $N_D \gg p$ ,  $n \sim N_D$

For any materials (intrinsic or extrinsic)

$$np = N_C N_V \exp \frac{-E_g}{kT} = n_i^2 = p_i^2$$

For n-type SC

$$p = \frac{N_C N_V}{N_D} \exp \frac{-E_g}{kT} = \frac{n_i^2}{N_D}$$

e.g.,  $10^{17} \text{ cm}^{-3}$  As doped Si  $\rightarrow$  electron density  $\sim 10^{17} \text{ cm}^{-3}$ , hole density  $\sim 460$   
 $\rightarrow$  majority carrier: electron

p-type

dopant (acceptor) density;  $N_A$ , electron density (by thermal promotion);  $n$   
→

total density of holes ( $p$ )

$$p = n + N_A$$

when  $N_A \gg n$ ,  $p = N_A \rightarrow$  hole; majority carriers

$$n = n_i^2 / N_A$$

e.g., Si:  $N_A = 5 \times 10^{16}$  acceptor/cm<sup>3</sup>,  $n \sim 4000$  cm<sup>-3</sup>

•compound semiconductor (e.g., GaAs or TiO<sub>2</sub>); n-type or p-type → replacement of impurity atoms to the constituent lattice atoms, impurity atoms in an interstitial position, lattice vacancy or broken bond

e.g., n-TiO<sub>2</sub>: oxygen vacancies in the lattice

- extrinsic SC;  $E_F$  move up & down depending upon doping

$$E_F = E_V + kT \ln \left( \frac{N_V}{N_A} \right) \quad (\text{p-type semiconductor})$$

and donors move  $E_F$  up toward the conduction band:

$$E_F = E_C - kT \ln \left( \frac{N_C}{N_D} \right) \quad (\text{n-type semiconductor})$$

e.g.,  $10^{17} \text{ cm}^{-3}$  As doped Si  $\rightarrow N_D \sim 10^{17} \text{ cm}^{-3}$ ,  $N_C = 2.8 \times 10^{19} \text{ cm}^{-3}$ ,  $25^\circ \text{C}$

$$\Rightarrow E_F = E_C - (25.7 \times 10^{-3} \text{ eV}) \ln(N_C/N_D) \sim E_C - 0.13 \text{ eV}$$

- if  $N_D < N_C$ ,  $N_A < N_V \rightarrow \text{SC}$

- if higher doping levels; Fermi level moves into VB or CB  $\Rightarrow$  show metallic conductivity

e.g., transparent  $\text{SnO}_2$  ( $E_g = 3.5 \text{ eV}$ ) + heavily doping with Sb(III) ( $N_D > 10^{19} \text{ cm}^{-3}$ )  $\Rightarrow$  the material becomes conductive

## Fermi level

1) probability that an electronic level at energy  $E$  is occupied by an electron at thermal equilibrium  $f(E) \rightarrow$  Fermi-Dirac distribution function

$$f(E) = \frac{1}{1 + \exp [(E - E_F)/kT]}$$

- Fermi level  $E_F$ ; value of  $E$  for which  $f(E) = 1/2$  (equally probable that a level is occupied or vacant)
- At  $T = 0$ , all levels below  $E_F$  ( $E < E_F$ ) are occupied ( $f(E) \rightarrow 1$ ); all levels  $E > E_F$  vacant
- intrinsic SC:  $E_F$  in the middle of CB and VB edges

## 2) alternative definition of $E_F$ for a phase $\alpha$ : “electrochemical potential”

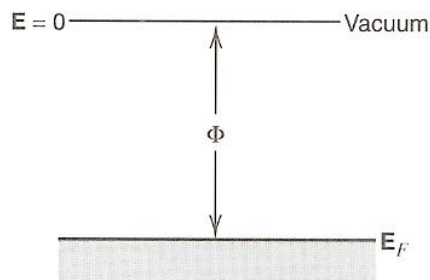
$$E_F^\alpha = \bar{\mu}_e^\alpha = \mu_e^\alpha - ze\phi^\alpha$$

where  $\bar{\mu}_e^\alpha$  is the *electrochemical potential* of electrons in phase  $\alpha$ ,  $\mu_e^\alpha$  is the chemical potential of electrons in this phase, and  $\phi^\alpha$  is the inner potential of  $\alpha$  (related to the electrical potential applied to the phase).

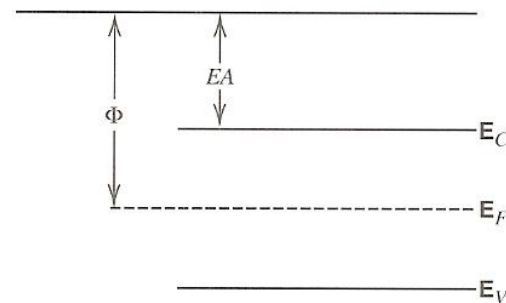
- useful in thermodynamic considerations of reactions and interfaces; at equilibrium electrically, the electrochemical potential of electrons in all phases must be same by charge transfer  $\rightarrow$  same Fermi level
- Fermi levels difference between two phases; function of the applied potential

### • Fermi level (uncharged phase) vs. work function ( $\Phi$ )

$$\Phi = -E_F$$



(a) Metal

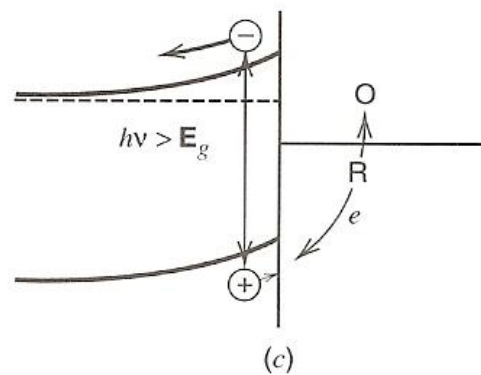
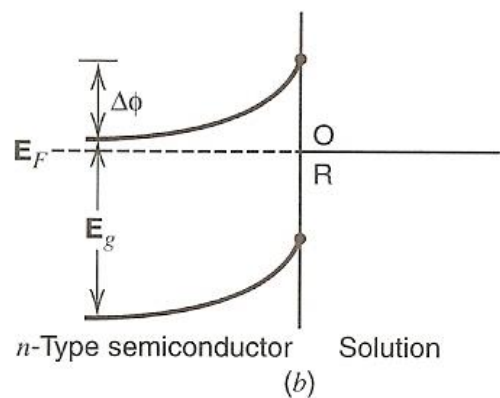
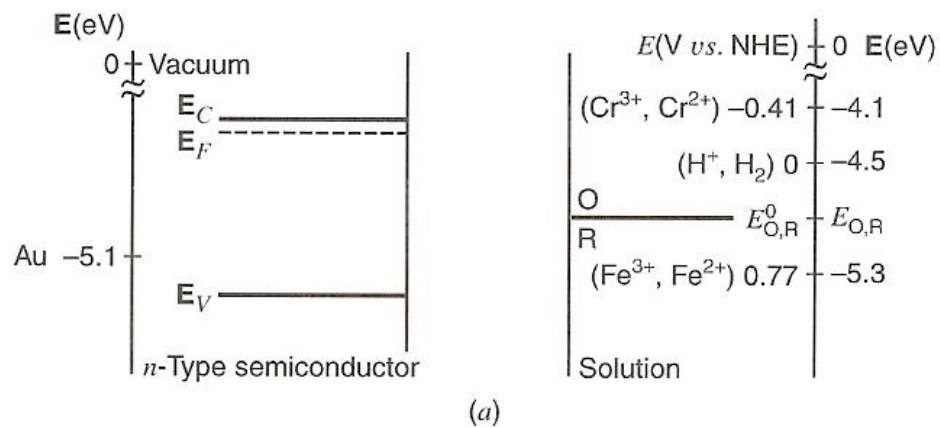


(b) Semiconductor

## Semiconductor/solution interface

- electron transfer at the interface (same principles as those given above) + chemical reaction (if possible, e.g., decomposition of SC , oxide film formation) → complicate
  - Si; SiO<sub>2</sub> (if oxygen or oxidant in solution); hinder electron transfer
- The distribution of charge ( $e^-/h^+$  in SC & ions in solution) and potential; depend on their relative Fermi level
- Fermi level in solution: electrochemical potential of electrons in solution phase ( )
  - governed by the nature and concentration of the redox species present in the solution and is directly related to the solution redox potential as calculated by the Nernst equation
  - at the point of zero charge, no surface state, no specifically adsorbed ions, no excess charge → the distribution of carriers ( $e^-$ ,  $h^+$ , anions, cations) is uniform from surface to bulk, and the energy bands are flat “ flat band potential” ( $E_{fb}$ ) ; no space charge layer in SC & no diffuse layer in solution

# n-type



- potential difference (by applied voltage or Fermi level difference) ; charged interface → space charge layer (thickness  $W$ ); potential difference  $\Delta V$ , dopant density  $N_D$

$$W \text{ (cm)} \approx 1.05 \times 10^3 \left[ \frac{\epsilon \Delta V \text{ (V)}}{N_D \text{ (cm}^{-3}\text{)}} \right]^{1/2}$$

50 ~ 2000 Å

- band bending: because of non uniform carrier density in SC (upward (with respect to the bulk SC) for a positively charged SC and downward for a negatively charged one) → electric field in the space charge region → direction of motion



## The capacitance of the space charge layer

$$C_{sc} = (2kTn_i\epsilon\epsilon_0)^{1/2} \cdot \frac{e}{2kT} \frac{-\lambda e^{-Y} + \lambda^{-1}e^Y + (\lambda - \lambda^{-1})}{[\lambda(e^{-Y} - 1) + \lambda^{-1}(e^Y - 1) + (\lambda - \lambda^{-1})]^{1/2}}$$

where  $\lambda = n_i/N_D$  and  $Y = e\Delta\phi/kT$ . This equation can be simplified under the conditions that a depletion layer exists (i.e.,  $\lambda e^{-Y} \ll \lambda^{-1}$ ). For an n-type semiconductor, when  $\lambda^{-1} \gg \lambda$ , this equation can be written with some rearrangement as

$$\frac{1}{C_{sc}^2} = \frac{2}{e\epsilon\epsilon_0 N_D} \left( -\Delta\phi - \frac{kT}{e} \right) \quad \text{Mott-Schottky plot}$$

which at 25°C, for  $C_{sc}$  in  $\mu\text{F}/\text{cm}^2$ ,  $N_D$  in  $\text{cm}^{-3}$ , and  $\Delta\phi = E_{fb} - E$  in volts is

$$\frac{1}{C_{sc}^2} = \frac{1.41 \times 10^{20}}{eN_D} [E - E_{fb} - 0.0257]$$

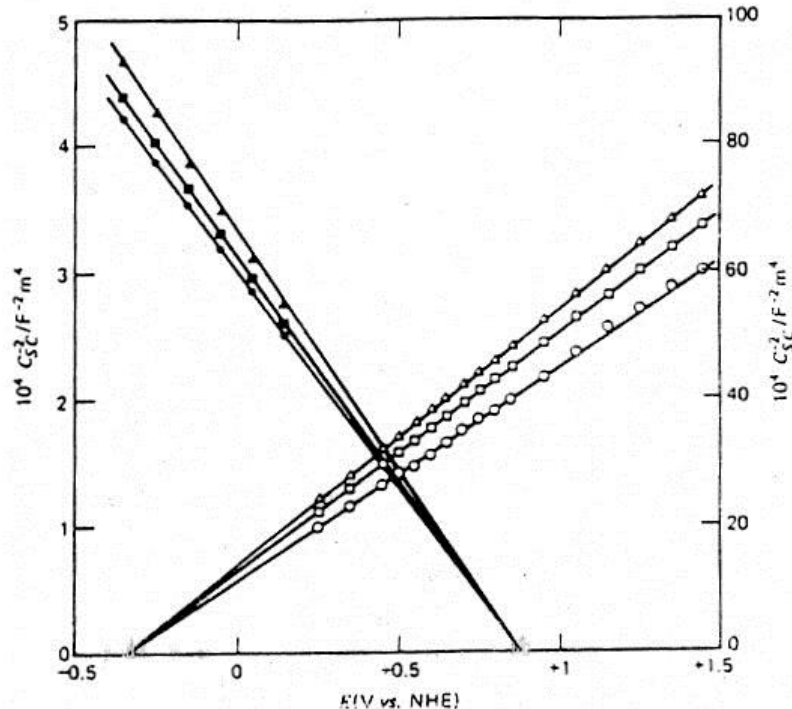
Mott-Schottky plot: useful in characterizing SC/liquid interface where a plot of  $(1/C_{sc}^2)$  vs.  $E$  should be linear  $\rightarrow$  values of  $E_{fb}$  and  $N_D$  from the intercept and slope

space charge capacitance  $C_{sc}$  → Mott-Schottly equation

$$1/C_{sc}^2 = (2/e\epsilon\epsilon_0 N)^{1/2}(-\Delta\phi - kT/e)$$

$\epsilon$ : dielectric constant,  $N$ : donor or acceptor densities,  $e$ : quantity of charge, -  
 $\Delta\phi = E - E_{fb}$

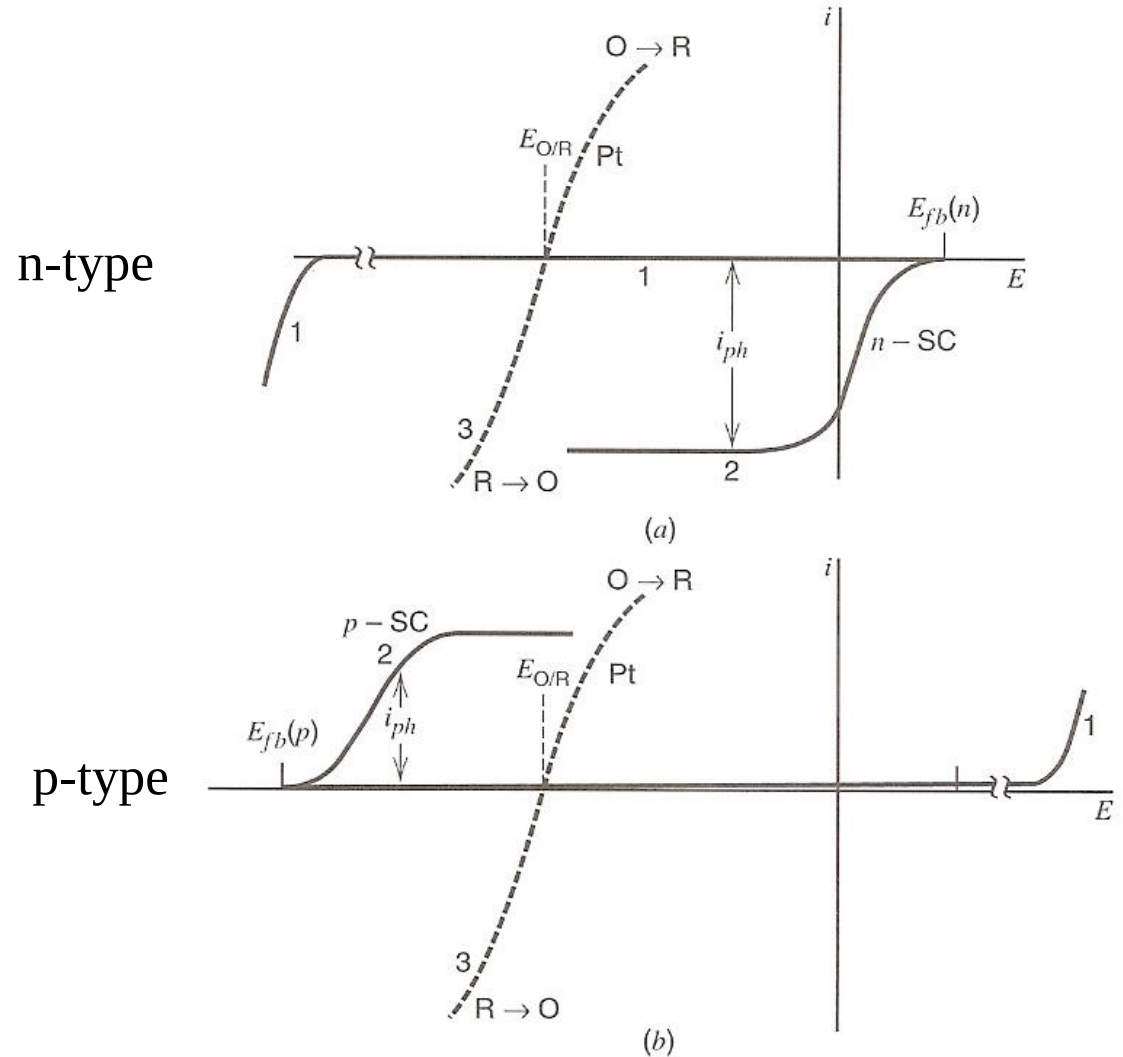
A plot of  $1/C_{sc}^2$  vs. potential  $E$  should be linear →  $E_{fb}$ , doping level  $N$



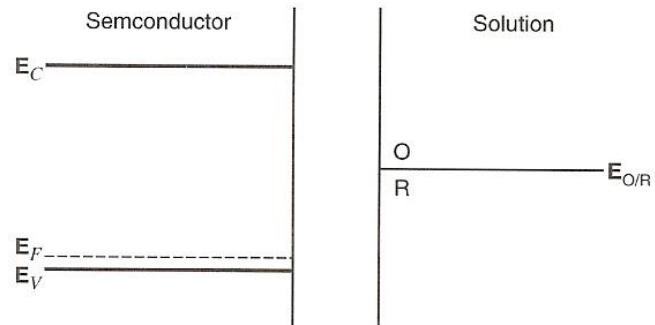
**Mott-Schottky plots for n- and p-type  
InP  
in 1 M KCl + 0.01 M HCl**

# Photoeffects at semiconductor electrodes

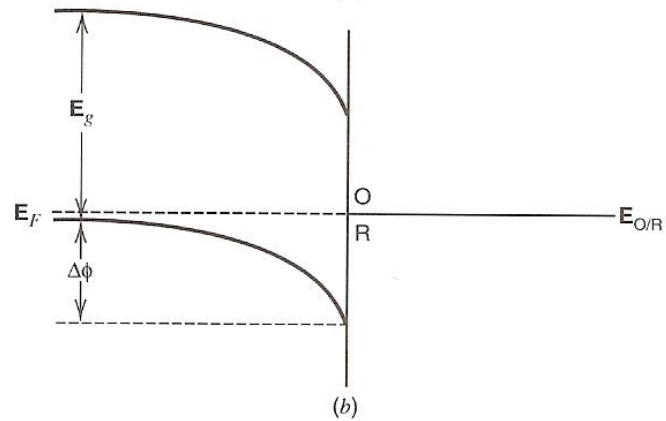
- 1: dark
- 2: irradiation
- 3: Pt electrode



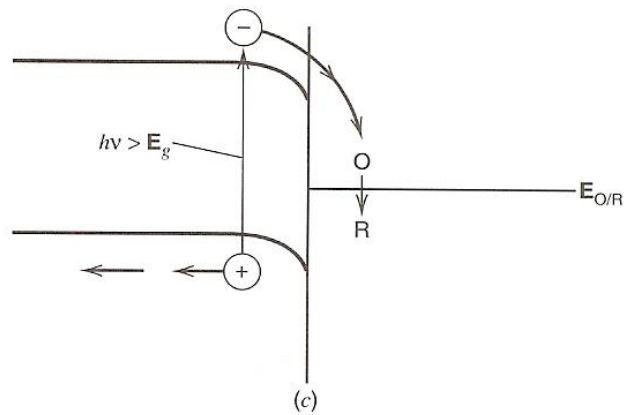
p-type



(a)



(b)



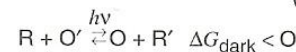
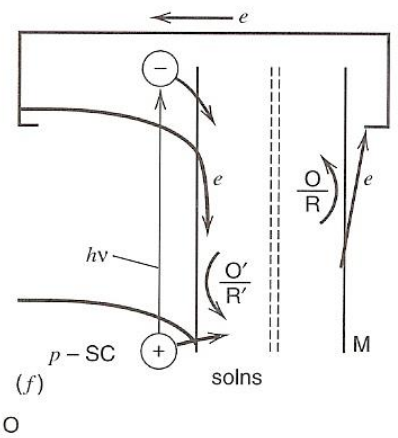
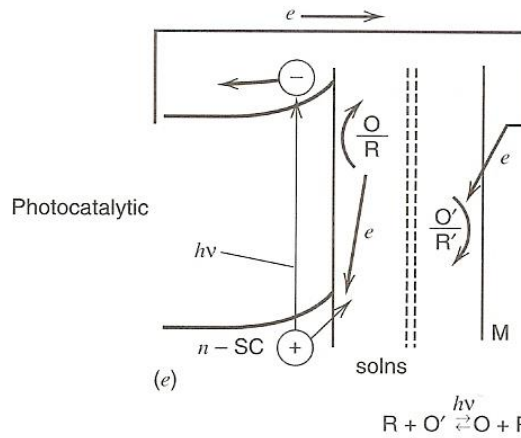
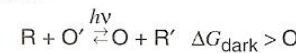
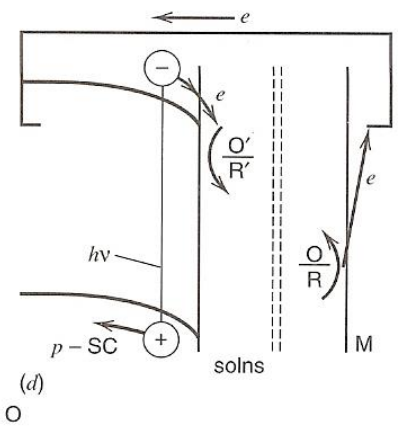
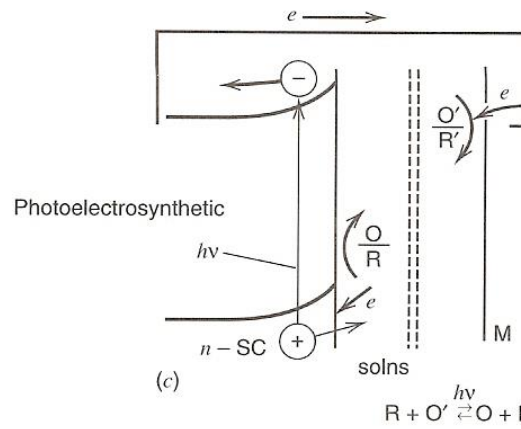
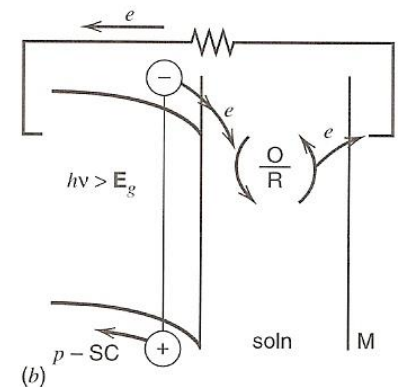
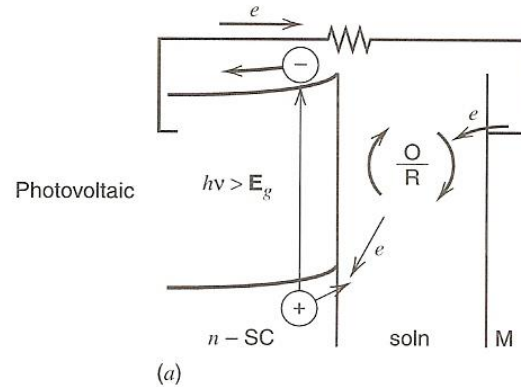
(c)

# Photoelectrochemical cells

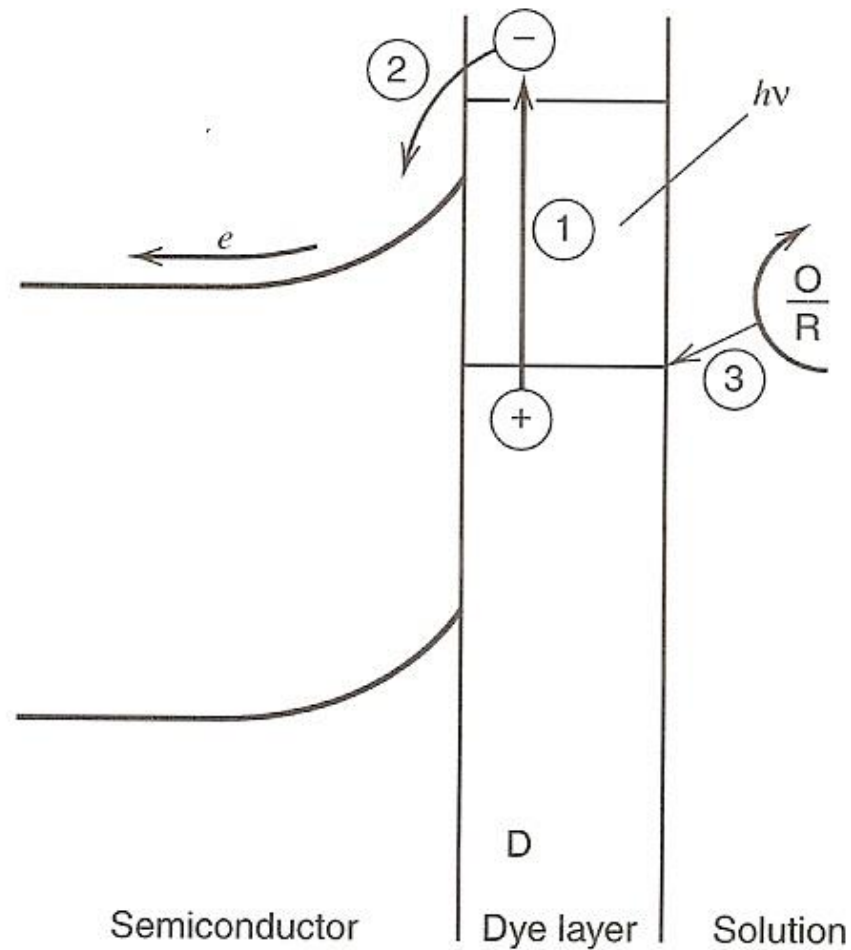
Photovoltaic cells:  
convert light to electricity

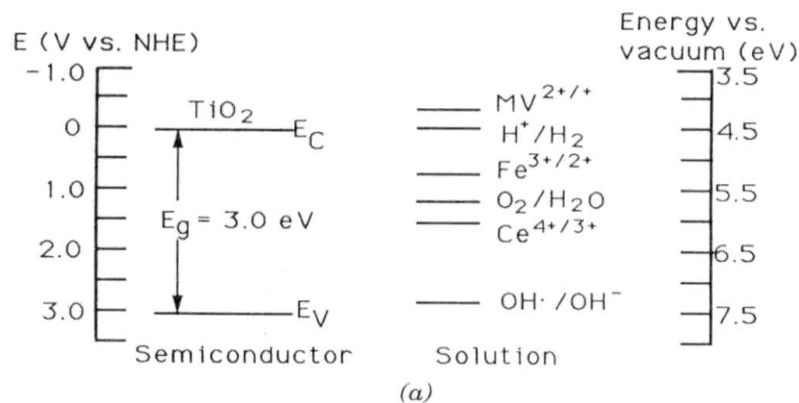
Photoelectrosynthetic cells:  
Radiant E to chemical energy

Photocatalytic cells:  
Light E to overcome  
activation E of the process

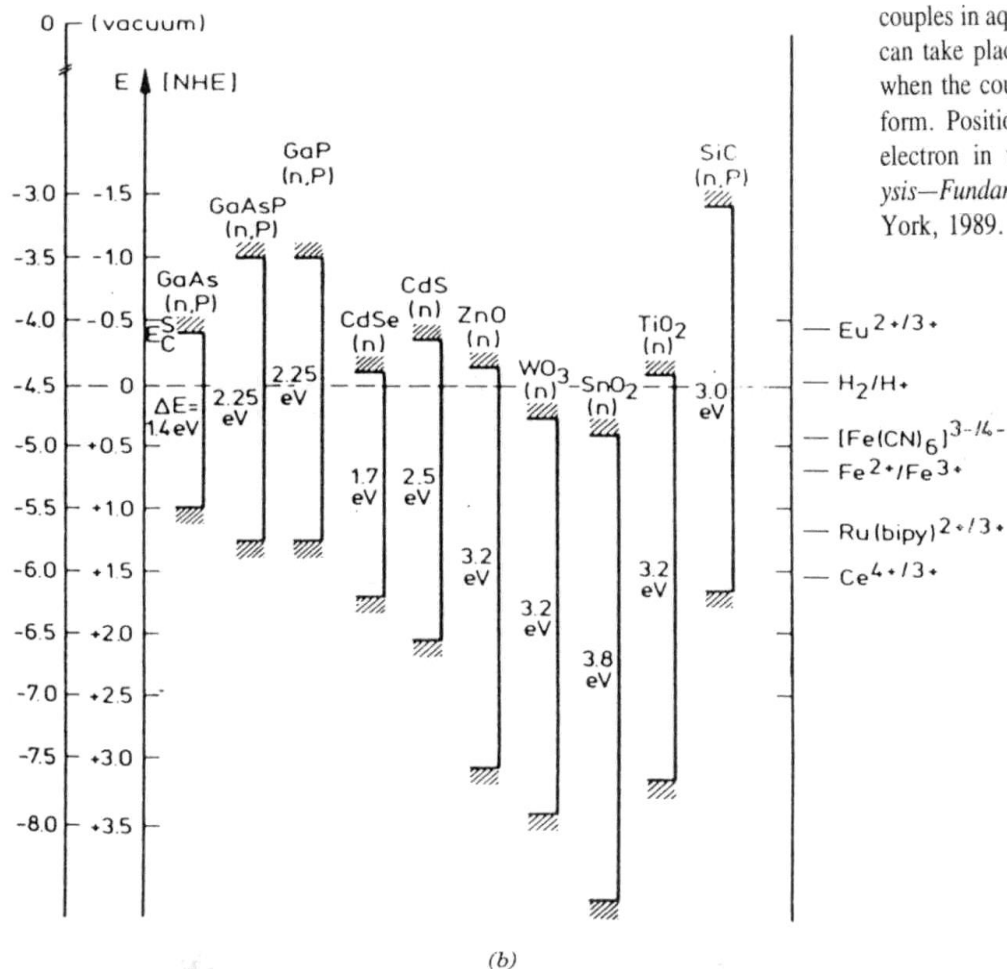


Band gap vs. wavelength  $\rightarrow$  limit to utilize sunlight (e.g.,  $\text{TiO}_2$  (3.0 eV))  
 $\rightarrow$  dye sensitization of a semiconductor

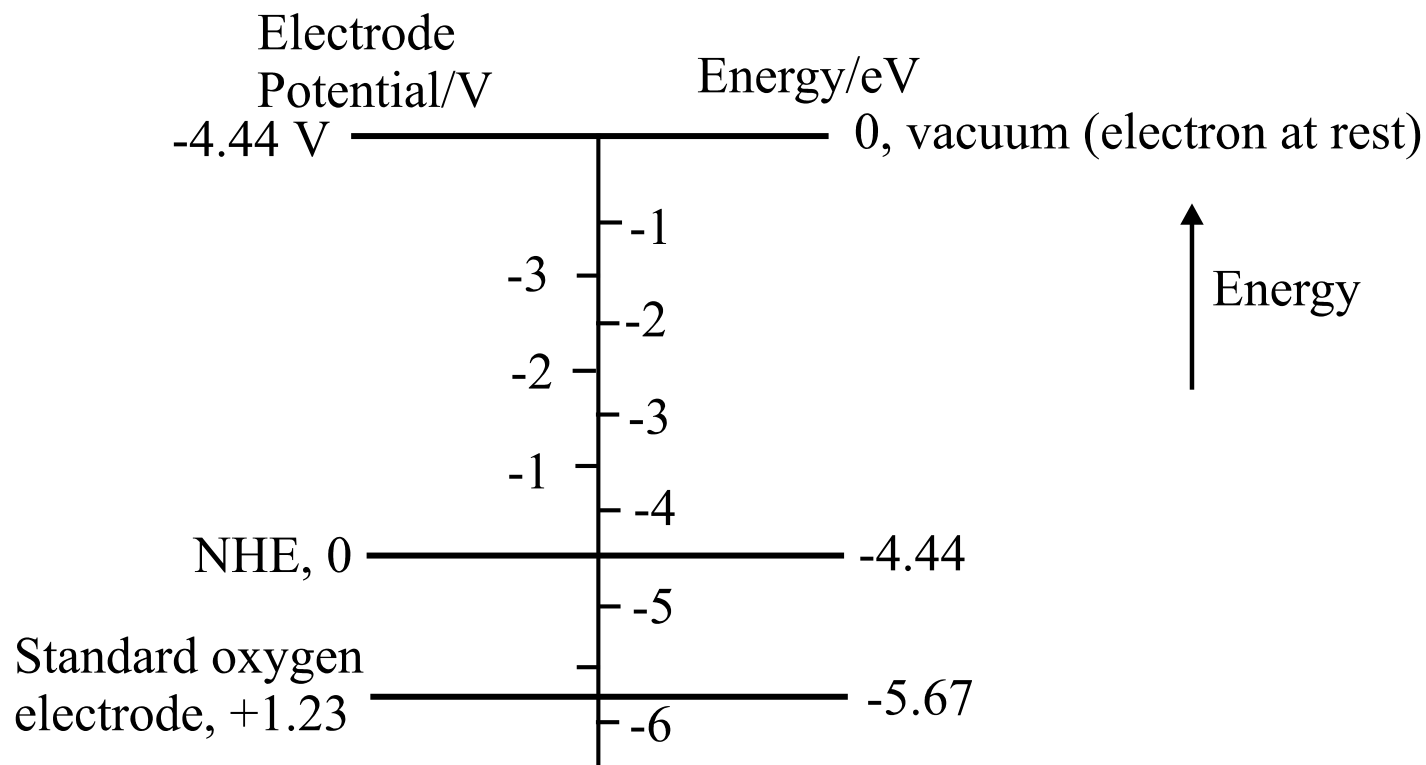




Band-edge positions of semiconductors with respect to several redox couples in aqueous solution at pH 1. (a)  $\text{TiO}_2$  in rutile form. Reduction by a CB electron can take place when the redox couple lies below  $E_C$ ; oxidation by a VB hole occurs when the couple lies above  $E_V$ . (b) Other semiconductors; here  $\text{TiO}_2$  is in the anatase form. Positions are given both as potentials versus NHE and as energies versus the electron in vacuum. [Reprinted with permission from M. Grätzel, in *Photocatalysis—Fundamentals and Applications*, N. Serpone and E. Pelizzetti, eds., Wiley, New York, 1989. Copyright © 1989 John Wiley & Sons.]



## Potential vs. energy (vs. vacuum)





## Photoelectrochemical photovoltaic cells

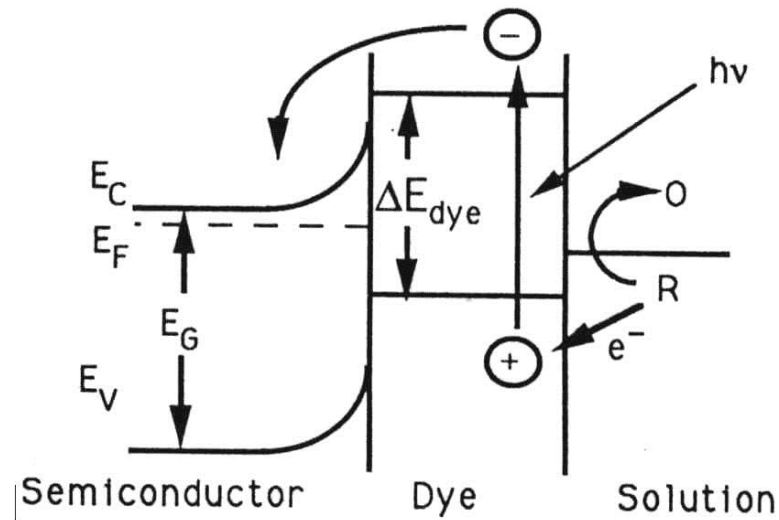
- basic idea
  - SC & counter electrodes in the same solution containing the redox couple  $D/D^+$
  - no net chemical reaction occurs in the solution during irradiation; hole oxidize  $D$  to  $D^+$  & electrons reduce  $D^+$  to  $D$
  - net effect: conversion of the radiant energy to electrical energy ( $h^+$  and  $e^-$ ) in the external circuit connecting the two electrodes
- Conversion efficiency depends on the quantum efficiency of the carrier generation, the rates of interfacial electron transfer, the rate of carrier recombination, internal cell resistance

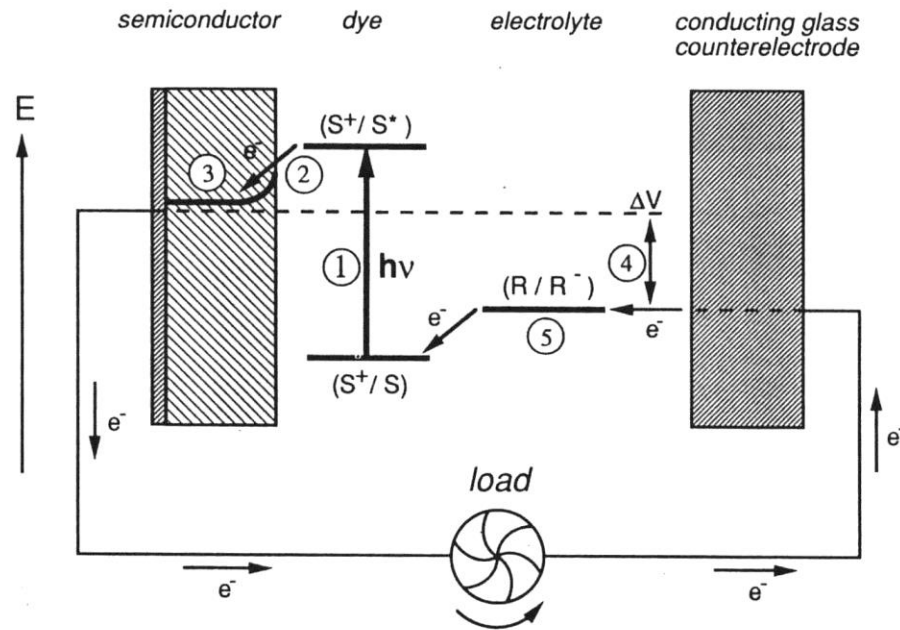
- Photoelectrochemical photovoltaic cells

Representative Liquid Junction Photovoltaic Cells

| Semiconductor           | $E_g$ (eV) | Redox System                            | Efficiency (%) | Ref. <sup>a</sup> |
|-------------------------|------------|-----------------------------------------|----------------|-------------------|
| n-GaAs (xyl)            | 1.4        | $\text{Se}_2^{2-}$ , $\text{Se}^{2-}$   | 12 (solar)     | 1, 2              |
| n-GaAs (poly)           | 1.4        | $\text{Se}_2^{2-}$ , $\text{Se}_2^{2-}$ | 7.8 (solar)    | 1, 3              |
| n-CdTe (xyl)            | 1.4        | $\text{Te}_2^{2-}$ , $\text{Te}_2^{2-}$ | 10 (632.8 nm)  | 4                 |
| n-Si (xyl)              | 1.1        | $\text{Fc}^{+/0}(\text{MeOH})$          | 10 (solar)     | 5                 |
| p-WS <sub>2</sub> (xyl) | 1.3        | $\text{Fc}^{+1/0}(\text{MeCN})$         | 7 (652.8 nm)   | 6                 |
| p-InP (xyl)             | 1.4        | $\text{V}^{3+/2+}$                      | 9.4 (solar)    | 7                 |

- photoactive dyes adsorbed or covalently attached to the electrode surface
  - to sensitize the electrode to visible light and produce photocurrents under irradiation with light of smaller energy than that corresponding to the SC band gap
  - principle: absorption of light in the dye layer (smaller energy than SC band gap) → injection of electrons to CB of SC; hole in dye filled by electron transfer from solution species (R to O)





Dye sensitization of semiconductor electrode. (A) Principles. (B) Schematic representation of  $\text{TiO}_2/\text{dye}/\text{I}^-$ ,  $\text{I}_2/\text{ITO}$  cell (see text) ( $\Delta V$  corresponds to the open-circuit photovoltage developed in the cell; S, dye sensitizer; S\*, electronically excited sensitizer; S<sup>+</sup>, oxidized sensitizer; R, iodine; R<sup>-</sup>, iodide). [Reprinted, with permission from *Nature*, from B. O'Regan and M. Grätzel, *Nature*, **353**, 737 (1991). Copyright 1991 Macmillan Magazines Limited.]

e.g., liquid junction photovoltaic cell  
dye sensitized SC:  $\text{TiO}_2$

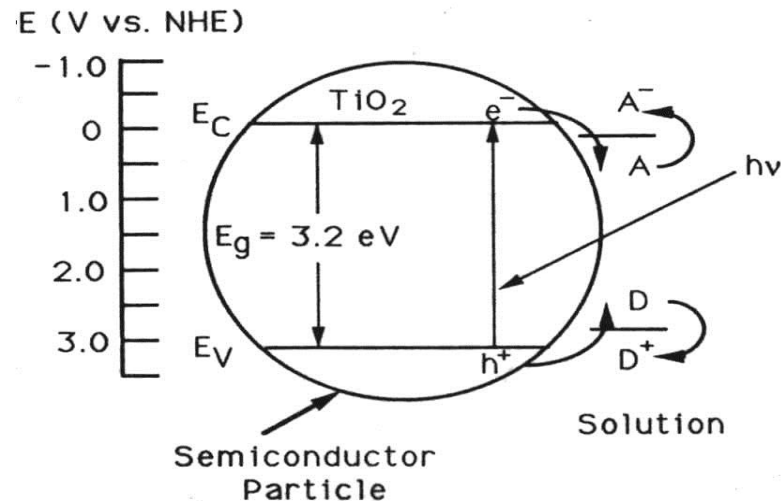
## Particulate SC systems

e.g., solar energy to produce fuels or to remove pollutants from water

- principles

- behave as microelectrode: carry out both anodic and cathodic half-reactions at different sites on the particle surface

e.g.,  $\text{TiO}_2$  particle:  $\text{CN}^-$  oxidation by  $\text{O}_2$  ( $\text{CN}^-$  oxidation +  $\text{O}_2$  reduction) by  $e^-h^+$  pair



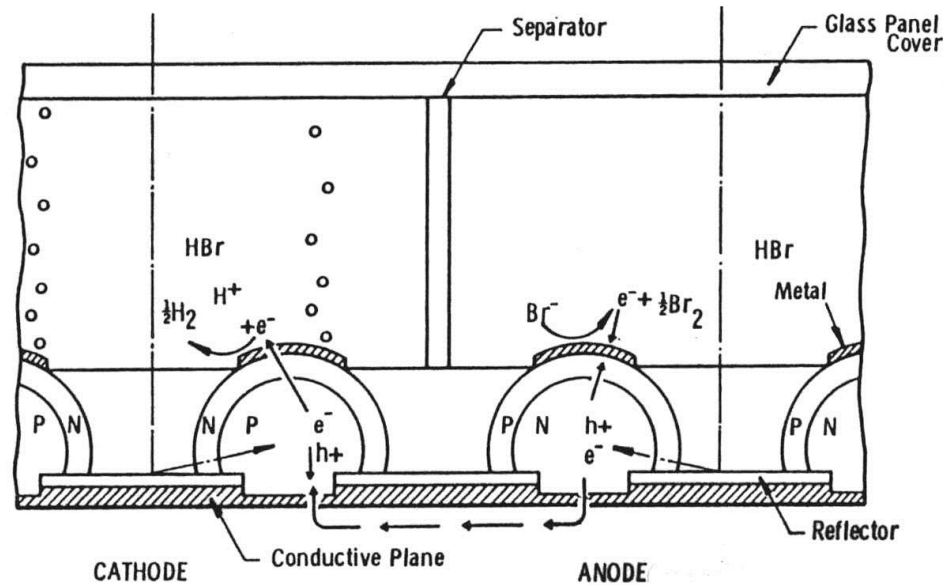
- particle dimensions < space charge layer ; charge separation by electric charge does not play a major role in promoting e<sup>-</sup>-h<sup>+</sup> separation
- trapping of charge at surface state maybe important in charge separation

Representative Photoreactions at Particulate Semiconductors

| Reactants                                            | Products                          | Semiconductors                                                      | Refs. <sup>a</sup> |
|------------------------------------------------------|-----------------------------------|---------------------------------------------------------------------|--------------------|
| CN <sup>-</sup> , O <sub>2</sub>                     | CNO <sup>-</sup>                  | TiO <sub>2</sub> , CdS, ZnO                                         | 1                  |
| CO <sub>2</sub> , H <sub>2</sub> O                   | CH <sub>3</sub> OH, HCHO          | TiO <sub>2</sub> , CdS, GaAs                                        | 2                  |
| CH <sub>4</sub> , NH <sub>3</sub> , H <sub>2</sub> O | Amino acids                       | Pt/TiO <sub>2</sub>                                                 | 3                  |
| Many organics, H <sub>2</sub> O                      | H <sub>2</sub> , CO <sub>2</sub>  | Pt/TiO <sub>2</sub>                                                 | 4                  |
| Many organics, O <sub>2</sub>                        | H <sub>2</sub> O, CO <sub>2</sub> | Pt/TiO <sub>2</sub>                                                 | 5                  |
| CH <sub>3</sub> COOH                                 | CH <sub>4</sub> , CO <sub>2</sub> | Pt/TiO <sub>2</sub>                                                 | 6                  |
| N <sub>2</sub> , H <sub>2</sub> O                    | NH <sub>3</sub>                   | TiO <sub>2</sub> , WO <sub>3</sub> , Fe <sub>2</sub> O <sub>3</sub> | 7                  |
| Ph <sub>2</sub> C=CH <sub>2</sub> , O <sub>2</sub>   | Ph <sub>2</sub> C=O               | TiO <sub>2</sub>                                                    | 8                  |
| H <sub>2</sub> S                                     | H <sub>2</sub> , S                | Pt/CdS, RuO <sub>2</sub> /CdS                                       | 9                  |

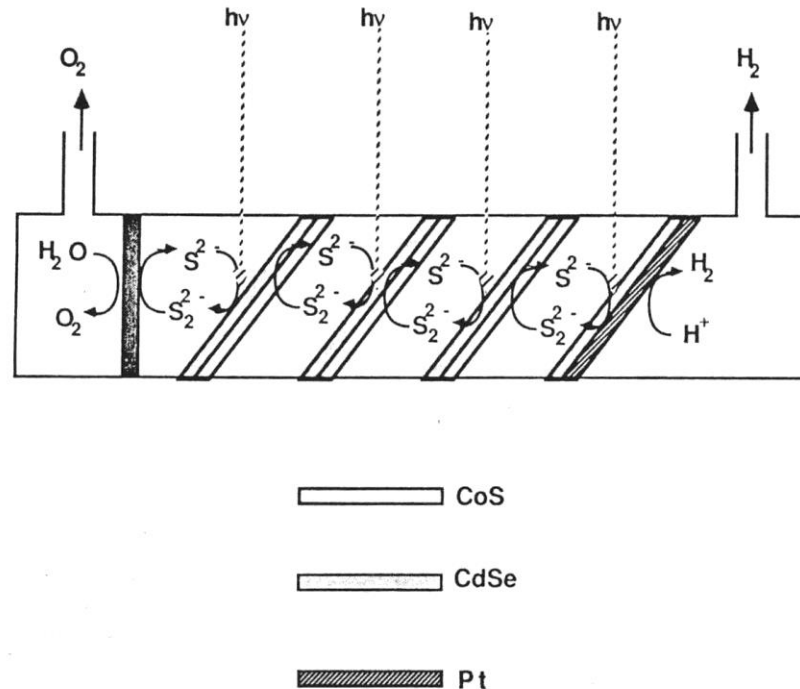
- supported SC particles
  - why? Prevent the flocculation & settling out of very small particles
  - if transparent support: high area thin films & small SC particle
  - support materials
    - polymer films or membranes: e.g., Nafion with Cd<sup>2+</sup>/H<sub>2</sub>S (CdS)
    - Inorganics (SiO<sub>2</sub>, clays, zeolites)
    - Organic supports: micelles, langmuir-Blodgett film with CdS

- Multijunction photoelectrochemical systems
  - limited single junction: splitting of water ( $< 0.8$  V open circuit photovoltage), p/n junction Si ( $\sim 0.55$  V), electric eel (one organ; 0.1 V  $\rightarrow$  in series, 500 V)
  - e.g., Texas Instrument Solar Energy System



Small ( $250\ \mu$ ) Si spheres (n-Si coated p-Si & p-Si coated n-Si)/glass matrix + catalyst; irradiation of the p/n junction produce 1.1 V  $\rightarrow$  decompose HBr to  $\text{H}_2 + \text{Br}_2$  ; other part;  $\text{H}_2 + \text{Br}_2$  produce electricity

- CdSe/Ti/CoS



Schematic diagram of a multielectrode array consisting of CdSe/CoS panels in series arranged in a cell for the photosplitting of water to  $\text{H}_2$  and  $\text{O}_2$  without an external bias. All solutions contain 1 M NaOH. The inner solutions also contain 1 M S and 1 M  $\text{Na}_2\text{S}$  (66). [Reprinted from A. J. Bard, *Ber. Bunsenges. Phys. Chem.* 92, 1187 (1988). Copyright 1988 VCH Verlagsgesellschaft.]



## Nano(or quantum, Q-) particles

- size quantization effect in Q-particles
    - particle size sufficiently small: electronic properties differ from that of bulk material
    - quantum dot, quantum wire, quantum particle
    - nano thickness layers: superlattices (different materials sandwiched)
  - band energetics of Q-particles
    - increase band gap
    - CB up and VB down: electrons are better reductants & holes are better oxidants in Q-particles
- e.g., enhanced photoredox chemistry at smaller particles of PbSe and HgSe

# Semiconductor particles

Grains

Nanocrystalline films

Quantum particles

(Q-particles or quantum dots)

